IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re New Patent Application of)	
Masaaki HIROKI)	
Japanese Priority Application No. 2000-168143) Attn: Applications	
Japanese Priority Date: June 5, 2000)	Branch
For:	DEVICE FOR INSPECTING ELEMENT)	
	SUBSTRATES AND METHOD OF)	
	INSPECTION USING THIS DEVICE) Date	: May 30, 2001

PRELIMINARY AMENDMENT

Honorable Commissioner for Patents

Washington, D.C. 20231

Sir:

Please preliminarily amend the subject application as follows:

IN THE SPECIFICATION:

Please amend the specification as follows: Please note that the specification is presented below in its amended form. It is further presented as an Attachment to the Amendment whereby the amendments to the specification are outlined using the conventional method of bracketing and underlining.

Page 11, under the heading BRIEF DESCRIPTION OF THE DRAWINGS, please amend paragraphs one and two as follows:

Figs. 1 (A), 1(B), and 1(C) are diagrams illustrating an inspection device of this invention;

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Figs. 2(A) and 2(B) are diagrams illustrating a pixel structure of the element substrate and of the opposing detector substrate of this invention;

On page 12, please amend paragraphs five and six as follows:

Figs. 13 (A) to 13(F) show electric appliances using the light-emitting device;

Figs. 14(A) to 14(C) show electric appliances using the light-emitting device;

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REMARKS

This application has been amended to properly describe Figures 1, 2, 13 and 14 in the Brief Description of the Drawings section of the subject application.

Examination on the merits is requested.

Respectfully submitted,

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VERSION WITH MARKINGS TO SHOW CHANGES MADE

[Fig 1 is a diagram] Figs. 1 (A), 1(B), and 1(C) are diagrams illustrating an inspection device of this invention;

[Fig. 2 is a diagram] <u>Figs. 2(A) and 2(B) are diagrams</u> illustrating a pixel structure of the element substrate and of the opposing detector substrate of this invention;

[Fig. 13 shows] <u>Figs. 13 (A) to 13(F)</u> show electric appliances using the light-emitting device;

[Fig. 14 shows] <u>Figs. 14(A) to 14(C) show</u> electric appliances using the light-emitting device;